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- Meet or Exceed TIA/EIA-232-F and ITU Recommendation V.28
- Operate With Single 5-V Power Supply
- Operate Up to 120 kbit/s
- Two Drivers and Two Receivers
- ±30-V Input Levels
- Low Supply Current . . . 8 mA Typical
- Designed to be Interchangeable With Maxim MAX232
- ESD Protection Exceeds JESD 22

 2000-V Human-Body Model (A114-A)
- Applications
 - TIA/EIA-232-F Battery-Powered Systems Terminals Modems Computers

MAX232I I	D, C	, N, OR NS PACKAGE W, OR N PACKAGE ? VIEW)
С1+ Ц	1	
V _{S+} [2	15 🛛 GND
C1– [3	14 🛛 T1OUT
C2+ [4	13 🛛 R1IN
C2- [5	12 🛛 R1OUT
V _{S-} [6	11 🛛 T1IN
T2OUT [7	10 🛛 T2IN
R2IN [8	9 R20UT

description/ordering information

The MAX232 is a dual driver/receiver that includes a capacitive voltage generator to supply EIA-232 voltage levels from a single 5-V supply. Each receiver converts EIA-232 inputs to 5-V TTL/CMOS levels. These receivers have a typical threshold of 1.3 V and a typical hysteresis of 0.5 V, and can accept ±30-V inputs. Each driver converts TTL/CMOS input levels into EIA-232 levels. The driver, receiver, and voltage-generator functions are available as cells in the Texas Instruments LinASIC[™] library.

TA	PAC	KAGE [†]	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	PDIP (N)	Tube	MAX232N	MAX232N
				IVIAA232IN
	SOIC (D)	Tube	MAX232D	MAX232
0°C to 70°C	0010 (D)	Tape and reel	MAX232DR	WIAX232
	SOIC (DW)	Tube	MAX232DW	MAX232
	3010 (DVV)	Tape and reel	MAX232DWR	IVIAA232
	SOP (NS)	Tape and reel	MAX232NSR	MAX232
	PDIP (N)	Tube	MAX232IN	MAX232IN
	SOIC (D)	Tube	MAX232ID	MAX232I
–40°C to 85°C	30IC (D)	Tape and reel	MAX232IDR	IVIAA2321
	SOIC (DW)	Tube	MAX232IDW	MAX232I
	3010 (DW)	Tape and reel	MAX232IDWR	101772321

ORDERING INFORMATION

Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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Function Tables

EACH	DRIVER
ЕАСП	DRIVER

INPUT TIN	OUTPUT TOUT
L	Н
н	L
H = high I	evel. L = low

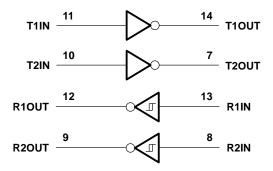
H = high level, L = lo

EACH RECEIVER

INPUT RIN	OUTPUT ROUT			
L	Н			
н	L			
H - bigh I				

H = high level, L = low level

logic diagram (positive logic)





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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Input supply voltage range, V _{CC} (see Note 1) .		–0.3 V to 6 V
Positive output supply voltage range, V _{S+}		
Negative output supply voltage range, V _S	-	. –0.3 V to –15 V
Input voltage range, VI: Driver	0.3	V to V_{CC} + 0.3 V
Receiver		±30 V
Output voltage range, V _O : T1OUT, T2OUT	V _S 0.3	V to V _{S+} + 0.3 V
R1OUT, R2OUT		V to V_{CC} + 0.3 V
Short-circuit duration: T1OUT, T2OUT		Unlimited
Package thermal impedance, θ_{JA} (see Note 2):	D package	73°C/W
	DW package	57°C/W
	N package	67°C/W
	NS package	
Lead temperature 1,6 mm (1/16 inch) from case	e for 10 seconds	260°C
Storage temperature range, T _{sta}		–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to network ground terminal.

2. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions

			MIN	NOM	MAX	UNIT
V _{CC}	Supply voltage		4.5	5	5.5	V
VIH	High-level input voltage (T1IN,T2IN)		2			V
VIL	Low-level input voltage (T1IN, T2IN)				0.8	V
R1IN, R2IN	Receiver input voltage				±30	V
т.	Operating free air temperature	MAX232	0		70	°C
Тд	Operating free-air temperature	MAX232I	-40		85	C

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Note 3 and Figure 4)

PARAMETER	TEST CONDITIONS	MIN	түр‡	MAX	UNIT
ICC Supply current	$V_{CC} = 5.5 \text{ V},$ All outputs open, $T_A = 25^{\circ}C$		8	10	mA

[‡] All typical values are at V_{CC} = 5 V and T_A = 25°C. NOTE 3: Test conditions are C1–C4 = 1 μ F at V_{CC} = 5 V ± 0.5 V.



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DRIVER SECTION

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature range (see Note 3)

PARAMETER		TEST CONDITIONS	MIN	TYP†	MAX	UNIT	
VOH	High-level output voltage	T1OUT, T2OUT	$R_L = 3 k\Omega$ to GND	5	7		V
VOL	Low-level output voltage [‡]	T1OUT, T2OUT	$R_L = 3 k\Omega$ to GND		-7	-5	V
r _o	Output resistance	T1OUT, T2OUT	$V_{S+} = V_{S-} = 0, \qquad V_O = \pm 2 V$	300			Ω
los§	Short-circuit output current	T1OUT, T2OUT	$V_{CC} = 5.5 V$, $V_{O} = 0$		±10		mA
IIS	Short-circuit input current	T1IN, T2IN	$V_{I} = 0$			200	μΑ

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[‡] The algebraic convention, in which the least positive (most negative) value is designated minimum, is used in this data sheet for logic voltage levels only.

§ Not more than one output should be shorted at a time.

NOTE 3: Test conditions are C1–C4 = 1 μ F at V_{CC} = 5 V ± 0.5 V.

switching characteristics, $V_{CC} = 5 V$, $T_A = 25^{\circ}C$ (see Note 3)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
SR	Driver slew rate	$R_L = 3 k\Omega$ to 7 k Ω , See Figure 2			30	V/µs
SR(t)	Driver transition region slew rate	See Figure 3		3		V/µs
	Data rate	One TOUT switching		120		kbit/s

NOTE 3: Test conditions are C1–C4 = 1 μ F at V_{CC} = 5 V ± 0.5 V.

RECEIVER SECTION

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature range (see Note 3)

PARAMETER		TEST	CONDITIONS	MIN	TYP†	MAX	UNIT	
VOH	High-level output voltage	R1OUT, R2OUT	I _{OH} = -1 mA		3.5			V
VOL	Low-level output voltage‡	R1OUT, R2OUT	I _{OL} = 3.2 mA				0.4	V
VIT+	Receiver positive-going input threshold voltage	R1IN, R2IN	V _{CC} = 5 V,	$T_A = 25^{\circ}C$		1.7	2.4	V
VIT-	Receiver negative-going input threshold voltage	R1IN, R2IN	V _{CC} = 5 V,	$T_A = 25^{\circ}C$	0.8	1.2		V
V _{hys}	Input hysteresis voltage	R1IN, R2IN	$V_{CC} = 5 V$		0.2	0.5	1	V
rj	Receiver input resistance	R1IN, R2IN	V _{CC} = 5,	T _A = 25°C	3	5	7	kΩ

[†] All typical values are at $V_{CC} = 5 V$, $T_A = 25^{\circ}C$.

[‡] The algebraic convention, in which the least positive (most negative) value is designated minimum, is used in this data sheet for logic voltage levels only.

NOTE 3: Test conditions are C1–C4 = 1 μ F at V_{CC} = 5 V ± 0.5 V.

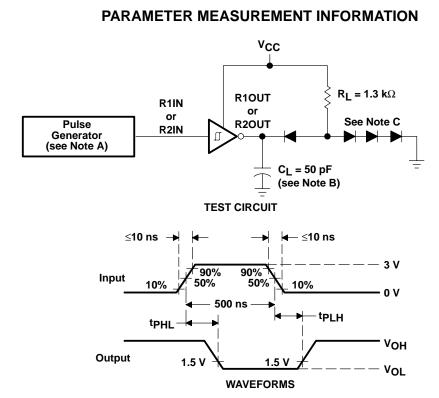
switching characteristics, $V_{CC} = 5 V$, $T_A = 25^{\circ}C$ (see Note 3 and Figure 1)

	PARAMETER	ТҮР	UNIT
^t PLH(R)	Receiver propagation delay time, low- to high-level output	500	ns
^t PHL(R)	Receiver propagation delay time, high- to low-level output	500	ns

NOTE 3: Test conditions are C1–C4 = 1 μ F at V_{CC} = 5 V ± 0.5 V.



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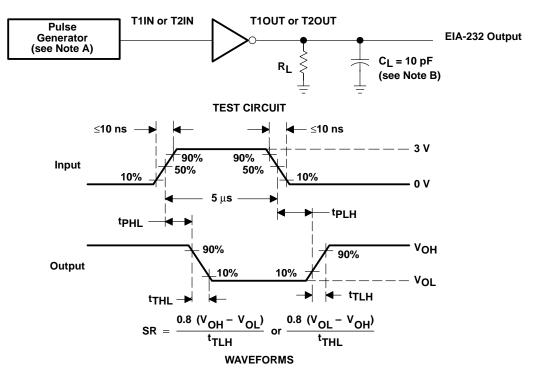


- NOTES: A. The pulse generator has the following characteristics: $Z_0 = 50 \Omega$, duty cycle $\leq 50\%$.
 - B. CL includes probe and jig capacitance.
 - C. All diodes are 1N3064 or equivalent.

Figure 1. Receiver Test Circuit and Waveforms for $t_{\mbox{PHL}}$ and $t_{\mbox{PLH}}$ Measurements



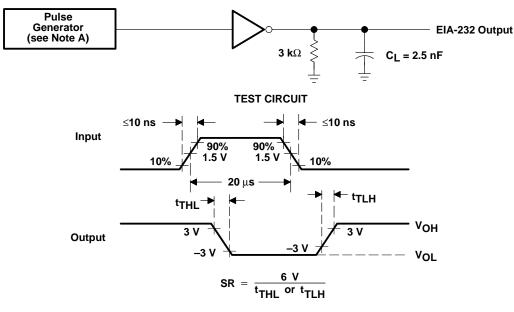
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PARAMETER MEASUREMENT INFORMATION

- NOTES: A. The pulse generator has the following characteristics: Z_{O} = 50 Ω , duty cycle \leq 50%.
 - B. C_L includes probe and jig capacitance.

Figure 2. Driver Test Circuit and Waveforms for tPHL and tPLH Measurements (5-µs Input)



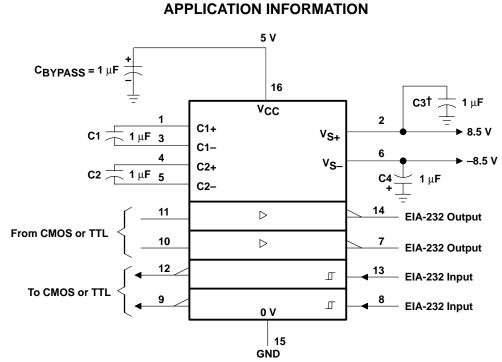
WAVEFORMS

NOTE A: The pulse generator has the following characteristics: $Z_0 = 50 \ \Omega$, duty cycle $\leq 50\%$.

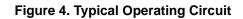
Figure 3. Test Circuit and Waveforms for t_{THL} and t_{TLH} Measurements (20- μs Input)



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 † C3 can be connected to V_{CC} or GND.





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